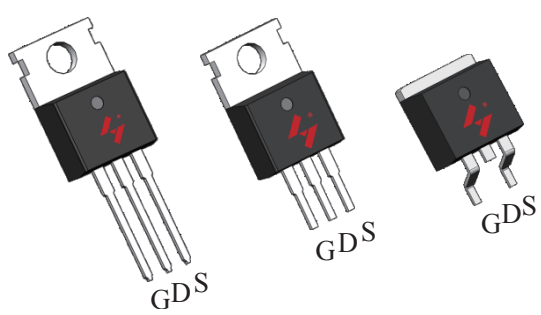


## N-Channel Enhancement Mode MOSFET

### Feature

- 45V/150A  
 $R_{DS(ON)} = 2.9m\Omega$  (typ.) @  $V_{GS} = 10V$   
 $R_{DS(ON)} = 3.4m\Omega$  (typ.) @  $V_{GS} = 4.5V$
- 100% Avalanche Tested
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

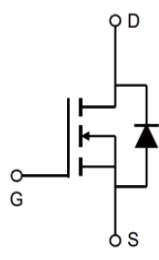
### Pin Description



TO-220FB-3L TO-220FB-3S TO-263-2L




### Applications

- Switching Application
- Power Management for DC/DC



N-Channel MOSFET

### Ordering and Marking Information

 P HY3404 AYMXXXXXX	 B HY3404 AYMXXXXXX	 M HY3404 AYMXXXXXX	Package Code P:TO-220FB-3L B:TO-263-2L M:TO-220FB-3S  Date Code AYMXXXXXX
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Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plate Termination finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines “Green” to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this product and/or to this document at any time without notice..

## Absolute Maximum Ratings

Symbol	Parameter		Rating	Unit
Common Ratings (Tc=25°C Unless Otherwise Noted)				
V <sub>DSS</sub>	Drain-Source Voltage		45	V
V <sub>GSS</sub>	Gate-Source Voltage		±20	V
T <sub>J</sub>	Maximum Junction Temperature		-55 to 175	°C
T <sub>STG</sub>	Storage Temperature Range		-55 to 175	°C
I <sub>S</sub>	Source Current-Continuous(Body Diode)	Tc=25°C	150	A
Mounted on Large Heat Sink				
I <sub>DM</sub>	Pulsed Drain Current *	Tc=25°C	530	A
I <sub>D</sub>	Continuous Drain Current	Tc=25°C	150	A
		Tc=100°C	102	A
P <sub>D</sub>	Maximum Power Dissipation	Tc=25°C	187.5	W
		Tc=100°C	93.7	W
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case**		0.8	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient		62.5	°C/W
E <sub>AS</sub>	SinglePulsed-Avalanche Energy ***	L=0.3mH	411	mJ

Note: \* Repetitive rating; pulse width limited by max.junction temperature.  
 \*\* Drain current is limited by junction temperature  
 \*\*\* Limited by T<sub>Jmax</sub>, starting T<sub>J</sub>=25°C, L = 0.3mH, V<sub>D</sub>= 32V, V<sub>GS</sub> =10V.

## Electrical Characteristics(Tc =25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	HY3404			Unit
			Min	Typ.	Max	
Static Characteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>DS</sub> =250μA	45	-	-	V
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>DS</sub> =45V, V <sub>GS</sub> =0V	-	-	1	μA
		T <sub>J</sub> =125°C	-	-	100	μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250μA	1.0	1.7	3.0	V
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =± 20V, V <sub>DS</sub> =0V	-	-	±100	nA
R <sub>DS(ON)*</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>DS</sub> =40A	-	2.9	3.6	mΩ
R <sub>DS(ON)*</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =4.5V, I <sub>DS</sub> =40A	-	3.4	4.3	mΩ
Diode Characteristics						
V <sub>SD</sub> *	Diode Forward Voltage	I <sub>SD</sub> =40A, V <sub>GS</sub> =0V	-	0.84	1.0	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> =20A, dI <sub>SD</sub> /dt=100A/μs	-	21	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge		-	14	-	nC

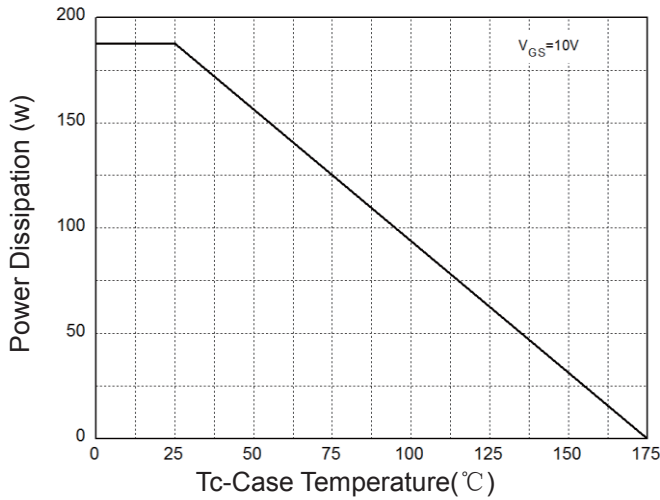
**Electrical Characteristics (Cont.)** (Tc =25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	HY3404			Unit
			Min	Typ.	Max	
Dynamic Characteristics						
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> =0V,V <sub>DS</sub> =0V, Frequency=1.0MHz	-	1.0	-	Ω
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, Frequency=1.0MHz	-	5129	-	pF
C <sub>oss</sub>	Output Capacitance		-	440	-	
C <sub>rss</sub>	Reverse Transfer Capacitance		-	230	-	
t <sub>d(ON)</sub>	Turn-on Delay Time	V <sub>DD</sub> =25V,R <sub>G</sub> =2.5Ω, I <sub>DS</sub> =40A,V <sub>GS</sub> =10V	-	14	-	ns
T <sub>r</sub>	Turn-on Rise Time		-	71	-	
t <sub>d(OFF)</sub>	Turn-off Delay Time		-	64	-	
T <sub>f</sub>	Turn-off Fall Time		-	105	-	
Gate Charge Characteristics						
Q <sub>g</sub>	Total Gate Charge (V <sub>GS</sub> =10V)	V <sub>DS</sub> =32V, I <sub>D</sub> =40A	-	102	-	nC
Q <sub>g</sub>	Total Gate Charge (V <sub>GS</sub> =4.5V)		-	48	-	
Q <sub>gs</sub>	Gate-Source Charge		-	13	-	
Q <sub>gd</sub>	Gate-Drain Charge		-	23	-	

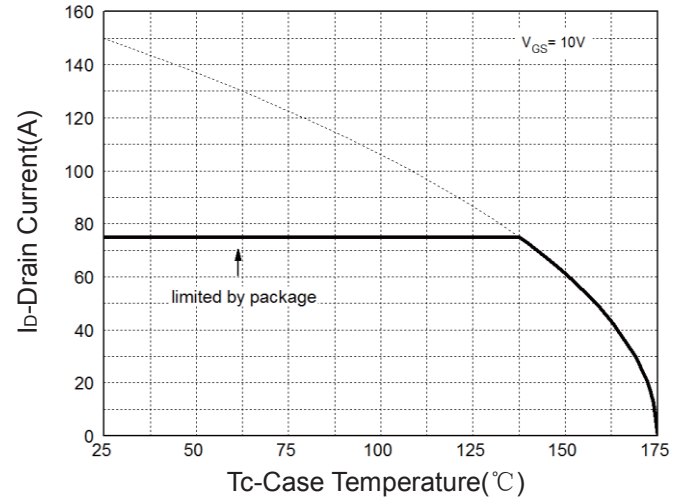
Note: \*Pulse test, pulse width ≤ 300us, duty cycle ≤ 2%

## Typical Operating Characteristics

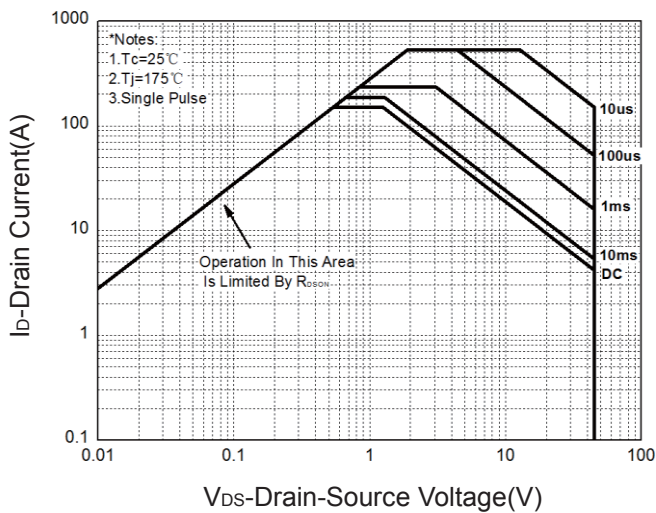
**Figure 1: Power Dissipation**



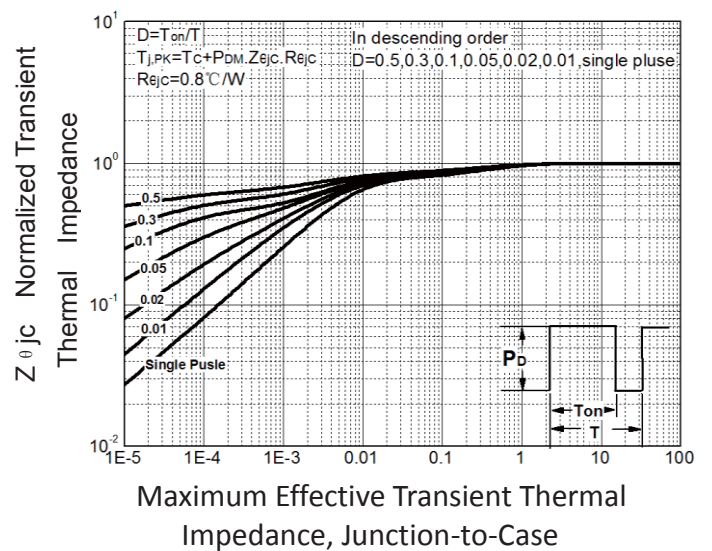
**Figure 2: Drain Current**



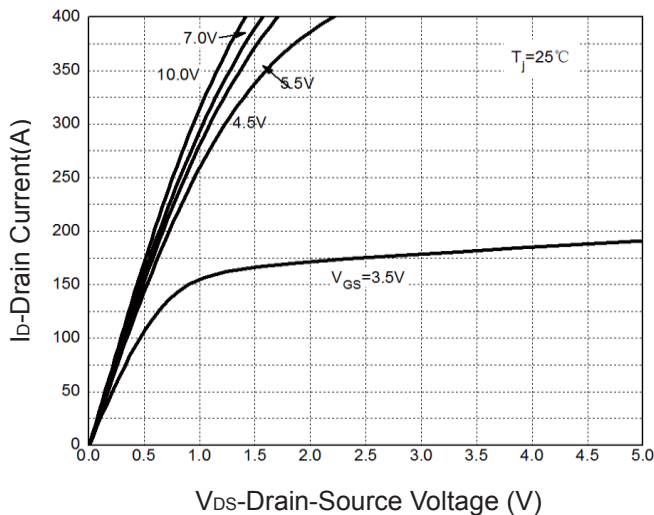
**Figure 3: Safe Operation Area**



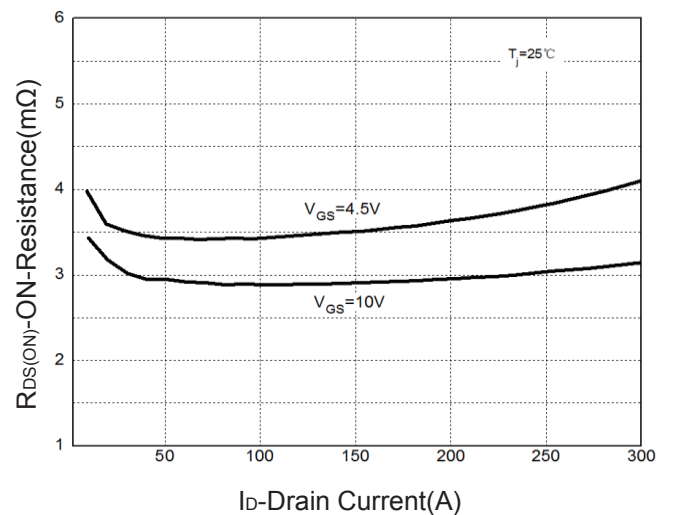
**Figure 4: Thermal Transient Impedance**



**Figure 5: Output Characteristics**

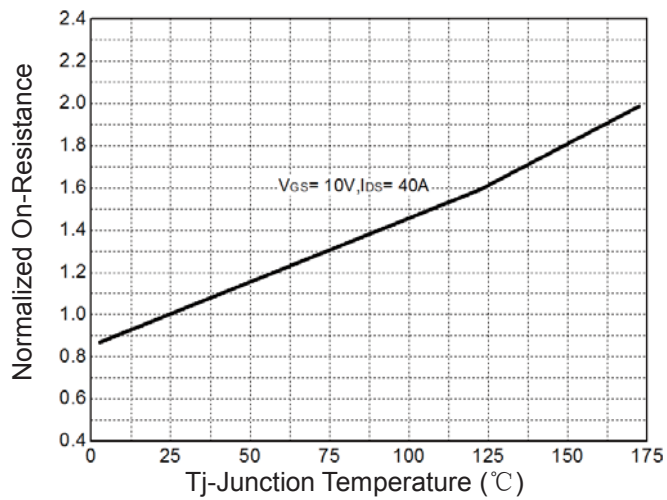


**Figure 6: Drain-Source On Resistance**

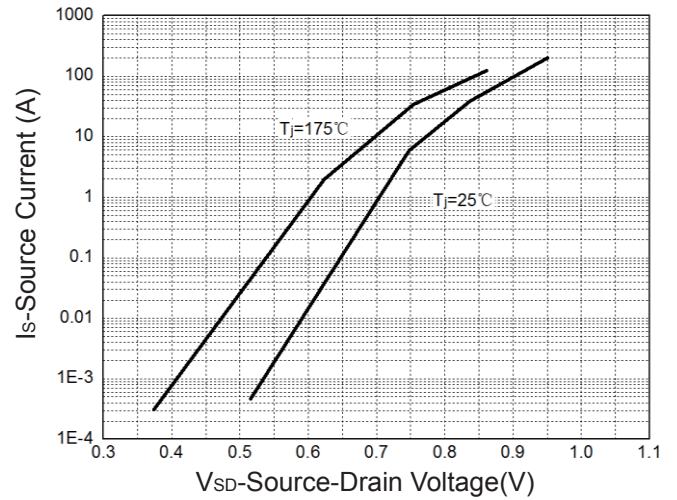


## Typical Operating Characteristics(Cont.)

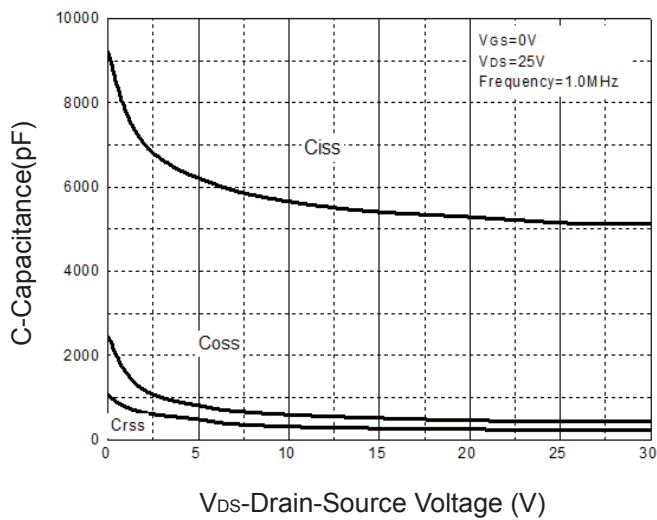
**Figure 7: On-Resistance vs. Temperature**



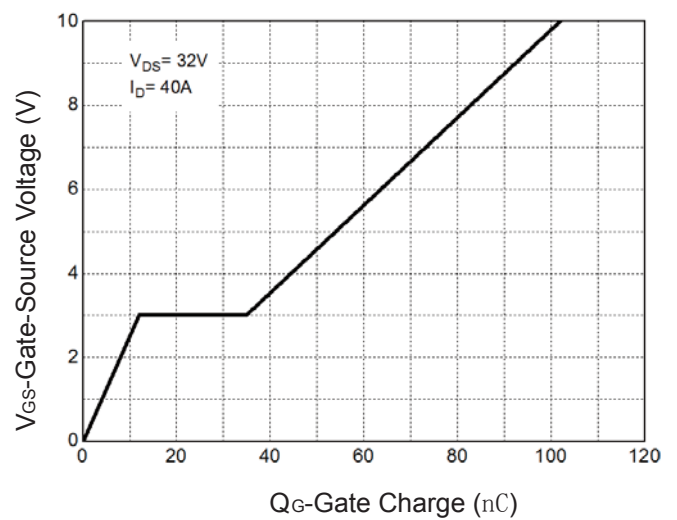
**Figure 8: Source-Drain Diode Forward**



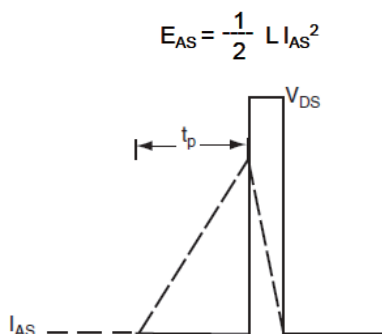
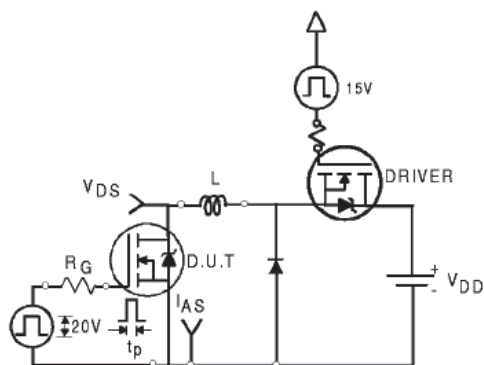
**Figure 9: Capacitance Characteristics**



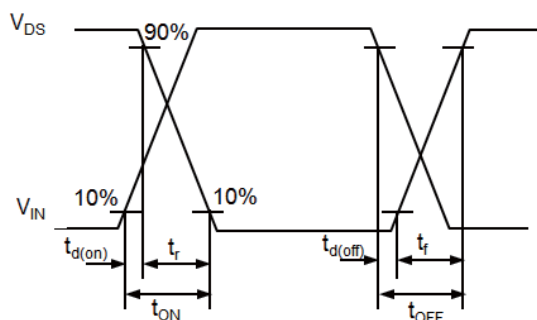
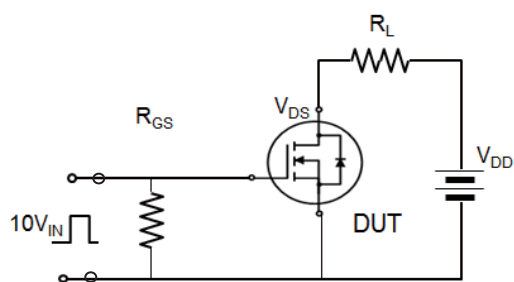
**Figure 10: Gate Charge Characteristics**



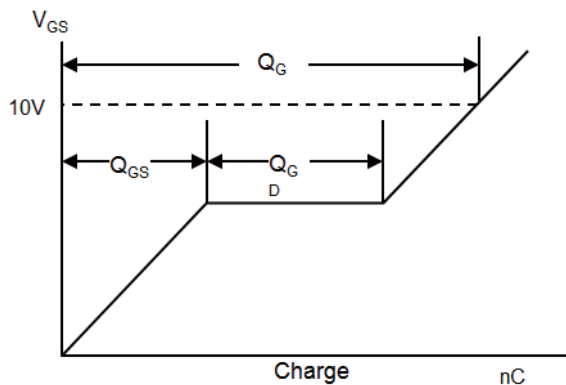
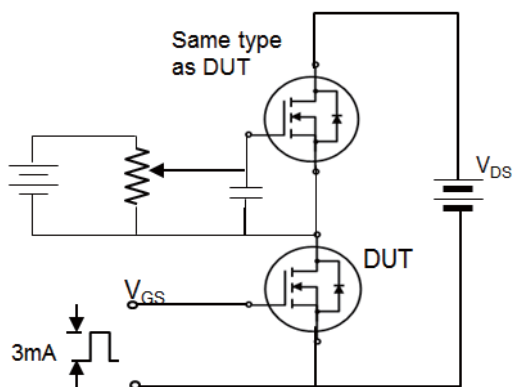
## Avalanche Test Circuit



## Switching Time Test Circuit



## Gate Charge Test Circuit

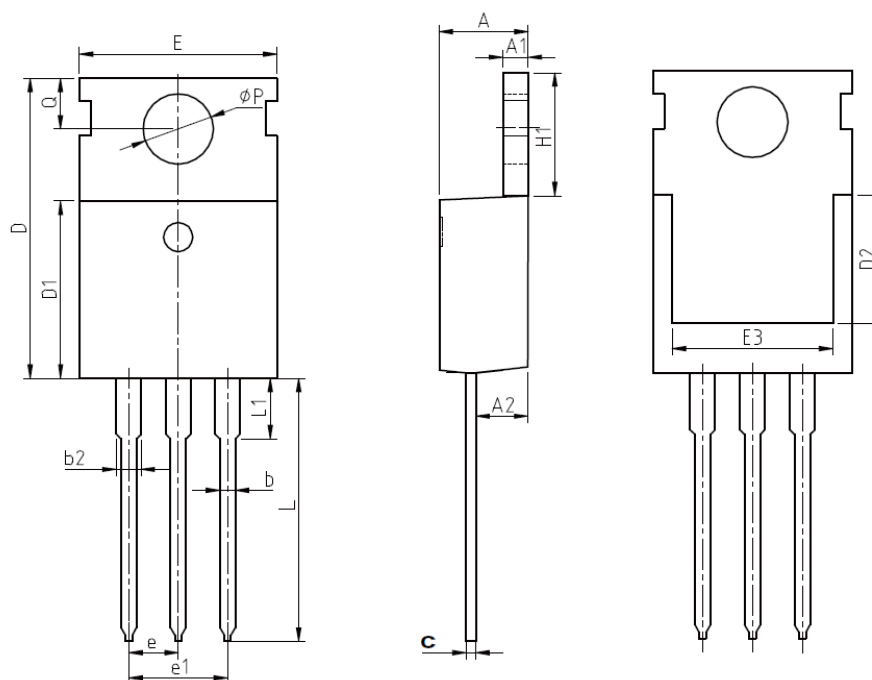


## Device Per Unit

Package Type	Unit	Quantity
TO-220FB-3L	Tube	50
TO-263-2L	Tube	50
TO-220FB-3S	Tube	50

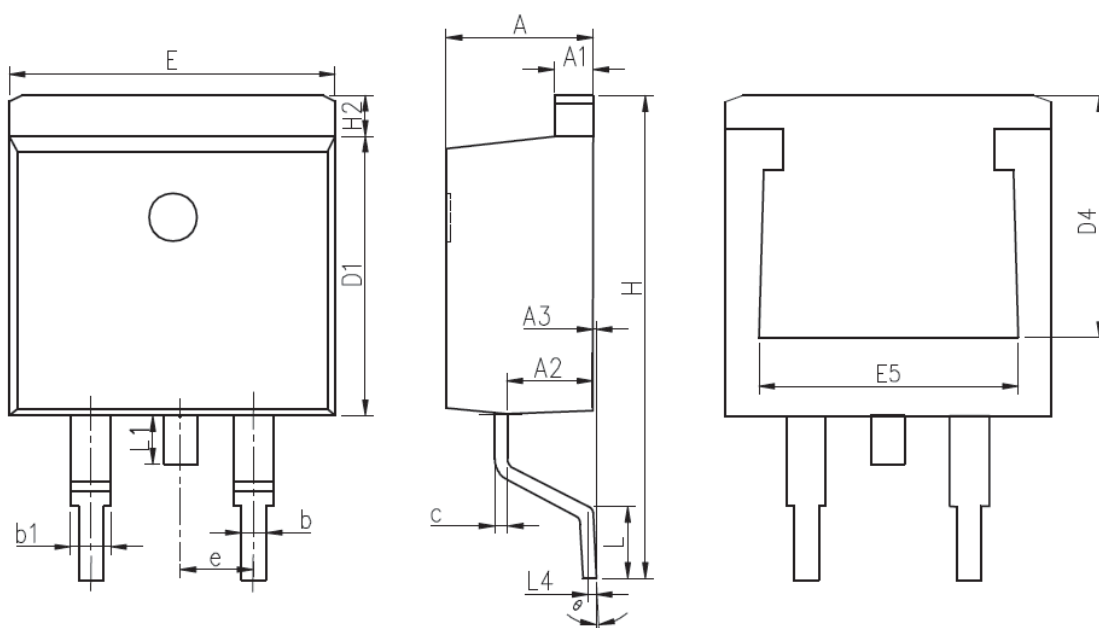
## Package Information

## TO-220FB-3L



COMMON DIMENSIONS

SYMBOL	mm		
	MIN	NOM	MAX
A	4.37	4.57	4.77
A1	1.25	1.30	1.45
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b2	1.17	1.27	1.47
c	0.40	0.50	0.65
D	15.10	15.60	16.10
D1	8.80	9.10	9.40
D2	5.50	-	-
E	9.70	10.00	10.30
E3	7.00	-	-
e	2.54 BSC		
e1	5.08 BSC		
H1	6.25	6.50	6.85
L	12.75	13.50	13.80
L1	-	3.10	3.40
ΦP	3.40	3.60	3.80
Q	2.60	2.80	3.00



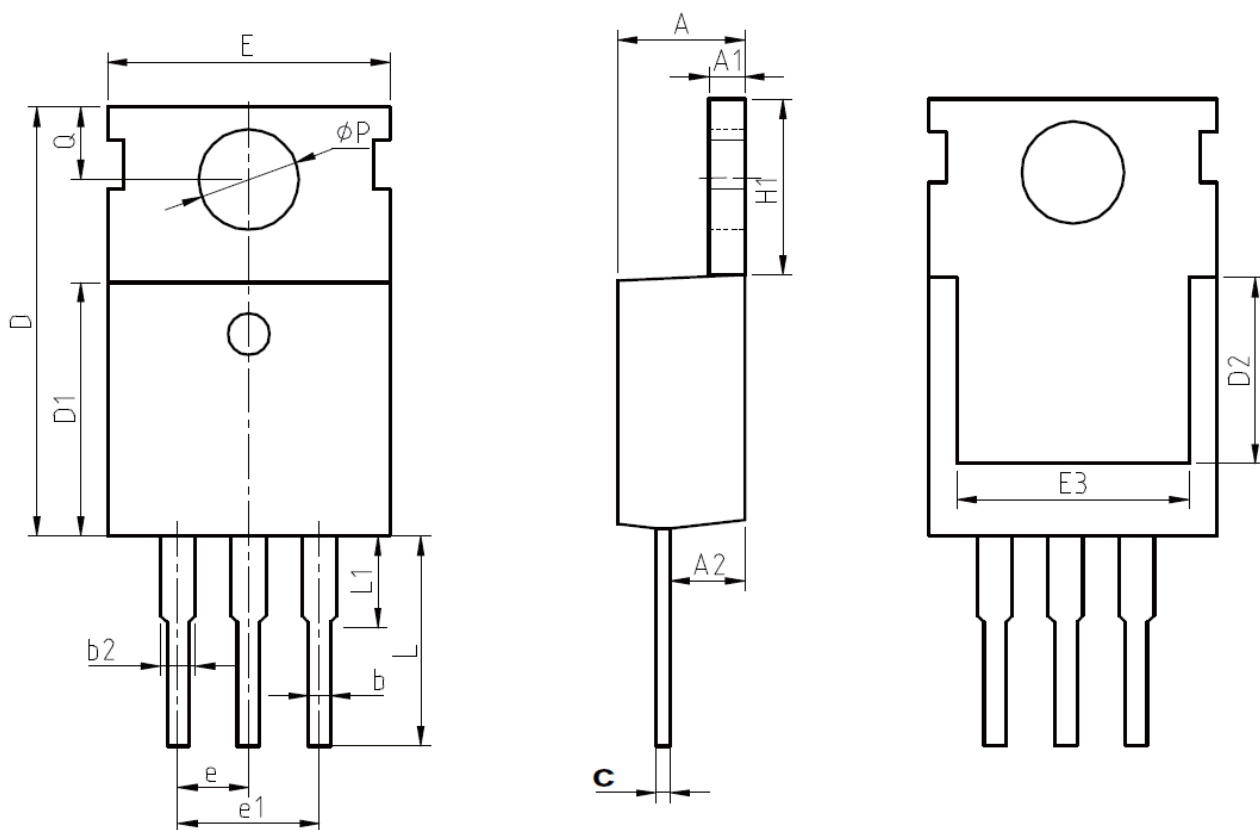
COMMON DIMENSIONS

SYMBOL	mm		
	MIN	NOM	MAX
A	4.37	4.57	4.77
A1	1.22	1.27	1.42
A2	2.49	2.69	2.89
A3	0	0.13	0.25
b	0.7	0.81	0.96
b1	1.17	1.27	1.47
c	0.3	0.38	0.53
D1	8.5	8.7	8.9
D4	6.6	-	-
E	9.86	10.16	10.36
E5	7.06	-	-
e	2.54 BSC		
H	14.7	15.1	15.5
H2	1.07	1.27	1.47
L	2	2.3	2.6
L1	1.4	1.55	1.7
L4	0.25 BSC		
θ	0°	5°	9°



# HY3404P/B/M

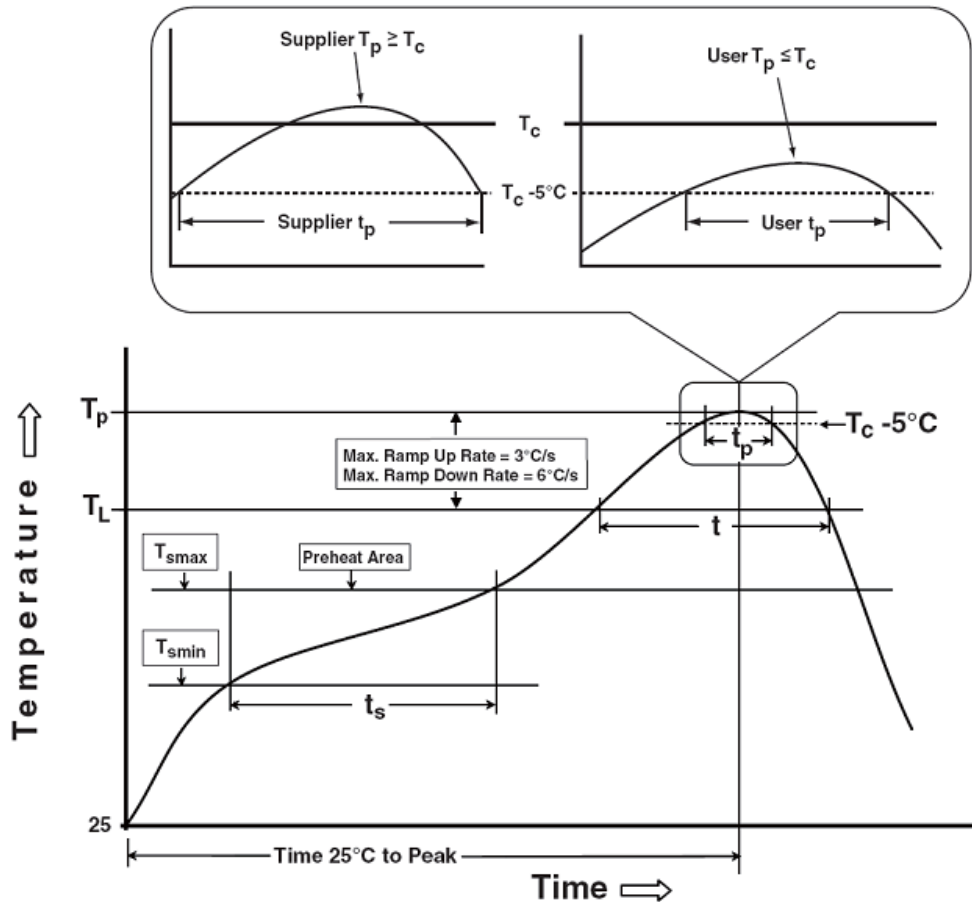
TO-220FB-3S



COMMON DIMENSIONS

SYMBOL	mm		
	MIN	NOM	MAX
A	4.37	4.57	4.77
A1	1.25	1.30	1.45
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b2	1.17	1.27	1.47
c	0.40	0.50	0.65
D	15.10	15.60	16.10
D1	8.10	9.10	9.40
D2	5.50	-	-
E	9.70	10.00	10.30
E3	7.00	-	-
e	2.54 BSC		
e1	5.08 BSC		
H1	6.25	6.50	6.85
L	6.80	7.00	7.20
L1	-	3.10	3.40
ΦP	3.40	3.60	3.80
Q	2.60	2.80	3.00

## Classification Profile



## Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
<b>Preheat &amp; Soak</b>		
Temperature min ( $T_{smin}$ )	100 °C	150 °C
Temperature max ( $T_{smax}$ )	150 °C	200 °C
Time ( $T_{smin}$ to $T_{smax}$ ) ( $t_s$ )	60-120 seconds	60-120 seconds
Average ramp-up rate ( $T_{smax}$ to $T_P$ )	3 °C/second max.	3°C/second max.
Liquidous temperature ( $T_L$ )	183 °C	217 °C
Time at liquidous ( $t_L$ )	60-150 seconds	60-150 seconds
Peak package body Temperature ( $T_P$ )*	See Classification Temp in table 1	See Classification Temp in table 2
Time ( $t_p$ )** within 5°C of the specified classification temperature ( $T_c$ )	20** seconds	30** seconds
Average ramp-down rate ( $T_P$ to $T_{smax}$ )	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
*Tolerance for peak profile Temperature ( $T_P$ ) is defined as a supplier minimum and a user maximum.		
** Tolerance for time at peak profile temperature ( $t_p$ ) is defined as a supplier minimum and a user maximum.		

Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

<b>Package Thickness</b>	<b>Volume mm<sup>3</sup> &lt;350</b>	<b>Volume mm<sup>3</sup> ≥350</b>
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

<b>Package Thickness</b>	<b>Volume mm<sup>3</sup> &lt;350</b>	<b>Volume mm<sup>3</sup> 350-2000</b>	<b>Volume mm<sup>3</sup> ≥2000</b>
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

## Reliability Test Program

<b>Test item</b>	<b>Method</b>	<b>Description</b>
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168 Hrs /500 Hrs /1000 Hrs, Bias @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

### Customer Service

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